BUK7C06-40AITE

N-channel TrenchPLUS standard level FET

Rev. 05 — 16 February 2009

Product data sheet

1. Product profile

1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. The devices include TrenchPLUS current sensing and diodes for ElectroStatic Discharge (ESD) protection and temperature sensing. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

1.2 Features and benefits

- Allows responsive temperature monitoring due to integrated temperature sensor
- Electrostatically robust due to integrated protection diodes
- Low conduction losses due to low on-state resistance
- Q101 compliant
- Reduced component count due to integrated current sensor

1.3 Applications

- Automotive and general purpose power switching
- Electrical Power Assisted Steering (EPAS)
- Fan control
- Variable valve timing for engines

1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	-	40	V
I _D	drain current	V_{GS} = 10 V; T_{mb} = 25 °C; see <u>Figure 2</u> ; [1] see <u>Figure 3</u>	-	-	155	Α
Static cha	racteristics					
R _{DSon}	drain-source on-state resistance	V_{GS} = 10 V; I_D = 50 A; T_j = 25 °C; see Figure 7; see Figure 8	-	4.7	6	mΩ
I _D /I _{sense}	ratio of drain current to sense current	$T_j > -55 ^{\circ}\text{C}; T_j < 175 ^{\circ}\text{C}; V_{GS} = 10 ^{\circ}\text{V}$	585	615	645	
S _{F(TSD)}	temperature sense diode temperature coefficient	$I_F = 250 \mu A; T_j > -55 \text{ °C}; T_j < 175 \text{ °C}$	-1.4	-1.54	-1.68	mV/K
V _{F(TSD)}	temperature sense diode forward voltage	$I_F = 250 \mu A; T_j = 25 °C$	648	658	668	mV

[1] Current is limited by power dissipation chip rating.



2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	ISENSE	Current sense	mb	D A
3	Α	anode		│ ╷ <u></u> ┵ <u>┐</u> │┃
4	D	drain	G G	G ↓ ↓ ↑ ↑ ↑ ↑
5	K	cathode		歩片
6	KS	Kelvin source		
7	S	source	SOT427	
mb	D	mounting base; connected to drain	(D2PAK)	l _{sense} Ś │ Ќ Kelvin source <i>sym110</i>

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BUK7C06-40AITE	D2PAK	plastic single-ended surface-mounted package (D2PAK); 7 leads (one lead cropped)	SOT427

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	40	V
V_{DGR}	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$		-	40	V
V _{GS}	gate-source voltage			-20	20	V
I _D	drain current	T _{mb} = 25 °C; V _{GS} = 10 V; see <u>Figure 2</u> ; see <u>Figure 3</u>	[1]	-	155	Α
			[2]	-	75	Α
		T _{mb} = 100 °C; V _{GS} = 10 V; see <u>Figure 2</u>	[2]	-	75	Α
I _{DM}	peak drain current	T_{mb} = 25 °C; $t_p \le 10 \mu s$; pulsed; see <u>Figure 3</u>		-	620	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 1</u>		-	272	W
I _{GS(CL)}	gate-source clamping	continuous		-	10	mA
	current	pulsed; $t_p = 5$ ms; $\delta = 0.01$		-	50	mA
V _{isol(FET-TS} D)	FET to temperature sense diode isolation voltage			-100	100	V
T _{stg}	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
Source-dra	ain diode					
Is	source current	$T_{mb} = 25 ^{\circ}C$	[1]	-	155	Α
			[2]	-	75	Α
I _{SM}	peak source current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$		-	620	Α
Avalanche	ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	I_D = 75 A; $V_{sup} \le 40$ V; R_{GS} = 50 Ω ; V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; unclamped		-	1.46	J
Electrostat	tic discharge					
V _{esd}	electrostatic discharge voltage	HBM; C = 100 pF; R = 1.5 kΩ		-	6	kV

^[1] Current is limited by power dissipation chip rating.

^[2] Continuous current is limited by package.

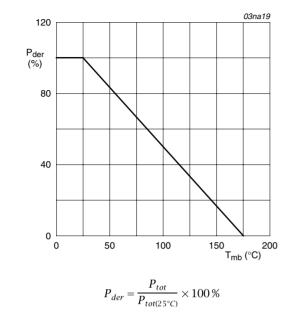


Fig 1. Normalized total power dissipation as a function of mounting base temperature

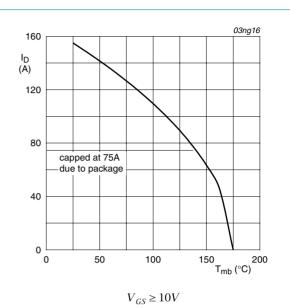
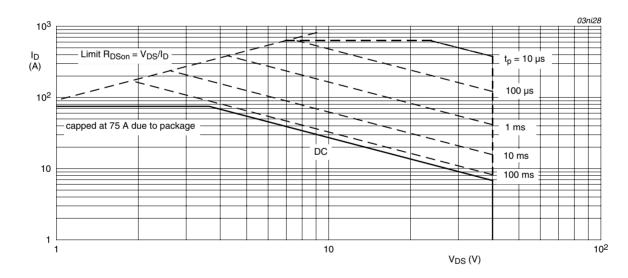


Fig 2. Continuous drain current as a function of mounting base temperature



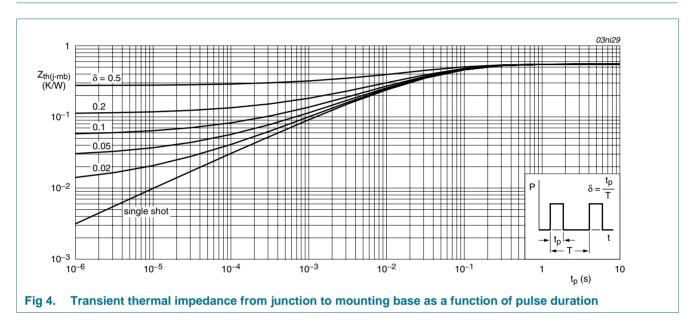
 $T_{mb} = 25$ °C; I_{DM} is single pulse

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	mounted on printed-circuit board; minimum footprint	-	-	50	K/W
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 4	-	-	0.55	K/W



6. Characteristics

Table 6. Characteristics

Table 6.	Characteristics			_		
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
$V_{(BR)DSS}$	drain-source	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	40	-	-	V
	breakdown voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$	36	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = 25 \text{ °C}$; see Figure 9	2	3	4	V
		$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = 175 \text{ °C}$; see Figure 9	1	-	-	V
		$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = -55 \text{ °C}$; see Figure 9	-	-	4.4	V
I _{DSS}	drain leakage current	$V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.1	10	μΑ
		V _{DS} = 40 V; V _{GS} = 0 V; T _j = 175 °C	-	-	250	μΑ
$V_{(BR)GSS}$	gate-source breakdown voltage	$I_G = 1 \text{ mA}; V_{DS} = 0 \text{ V}; T_j > -55 \text{ °C};$ $T_j < 175 \text{ °C}$	20	22	-	V
		$I_G = -1 \text{ mA}; V_{DS} = 0 \text{ V}; T_j > -55 \text{ °C};$ $T_j < 175 \text{ °C}$	20	22	-	V
I _{GSS}	gate leakage current	$V_{DS} = 0 \text{ V}; V_{GS} = 10 \text{ V}; T_j = 25 \text{ °C}$	-	22	1000	nA
		$V_{DS} = 0 \text{ V}; V_{GS} = -10 \text{ V}; T_j = 25 \text{ °C}$	-	22	1000	nA
		V _{DS} = 0 V; V _{GS} = 10 V; T _j = 175 °C	-	-	10	μΑ
		V _{DS} = 0 V; V _{GS} = -10 V; T _j = 175 °C	-	-	10	μΑ
R _{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 50 \text{ A}; T_j = 25 ^{\circ}\text{C};$ see Figure 7; see Figure 8	-	4.7	6	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 50 \text{ A}; T_j = 175 ^{\circ}\text{C};$ see Figure 7; see Figure 8	-	-	11.4	mΩ
V _{F(TSD)}	temperature sense diode forward voltage	$I_F = 250 \ \mu A; T_j = 25 \ ^{\circ}C$	648	658	668	mV
S _{F(TSD)}	temperature sense diode temperature coefficient	$I_F = 250 \mu A; T_j > -55 \text{ °C}; T_j < 175 \text{ °C}$	-1.4	-1.54	-1.68	mV/k
V _{F(TSD)hys}	temperature sense diode forward voltage hysteresis	$I_F > 125 \mu A; I_F < 250 \mu A; T_j = 25 °C$	25	32	50	mV
I _D /I _{sense}	ratio of drain current to sense current	$V_{GS} = 10 \text{ V}; T_j > -55 \text{ °C}; T_j < 175 \text{ °C}$	585	615	645	
Dynamic o	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 25 \text{ A}; V_{DS} = 32 \text{ V}; V_{GS} = 10 \text{ V};$	-	120	-	nC
Q _{GS}	gate-source charge	T _j = 25 °C; see <u>Figure 14</u>	-	19	-	nC
Q_{GD}	gate-drain charge		-	50	-	nC
C _{iss}	input capacitance	V _{GS} = 0 V; V _{DS} = 25 V; f = 1 MHz;	-	4300	-	pF
C _{oss}	output capacitance	$T_j = 25$ °C; see <u>Figure 12</u>	-	1400	-	pF
C _{rss}	reverse transfer capacitance		-	820	-	pF

Table 6. Characteristics ... continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
t _{d(on)}	turn-on delay time	V_{DS} = 30 V; R_L = 1.2 Ω ; V_{GS} = 10 V;	-	35	-	ns
t _r	rise time	$R_{G(ext)} = 10 \Omega; T_j = 25 °C$	-	115	-	ns
t _{d(off)}	turn-off delay time		-	155	-	ns
t _f	fall time		-	110	-	ns
L _D	internal drain inductance	measured from upper edge of drain mounting base to centre of die; $T_j = 25 ^{\circ}\text{C}$	-	2.5	-	nΗ
L _S	internal source inductance	measured from source lead to source bond pad; $T_j = 25 ^{\circ}\text{C}$	-	7.5	-	nΗ
Source-dr	rain diode					
V_{SD}	source-drain voltage	$I_S = 40 \text{ A}$; $V_{GS} = 0 \text{ V}$; $T_j = 25 \text{ °C}$; see Figure 18	-	0.85	1.2	V
t _{rr}	reverse recovery time	$I_S = 20 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s}; V_{GS} = -10 \text{ V};$	-	96	-	ns
Q _r	recovered charge	$V_{DS} = 30 \text{ V}; T_j = 25 \text{ °C}$	-	224	-	nC

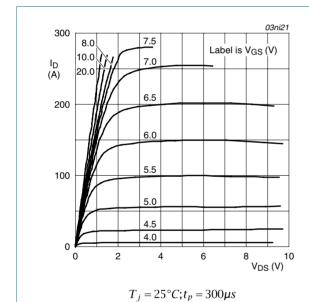


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

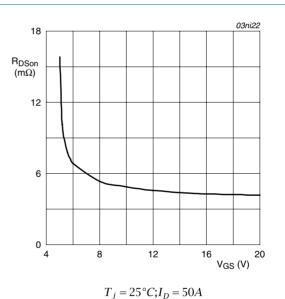
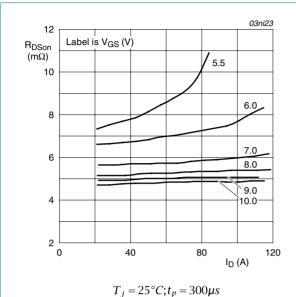


Fig 6. Drain-source on-state resistance as a function of gate-source voltage; typical values



g 7. Drain-source on-state resistance as a function of drain current; typical values

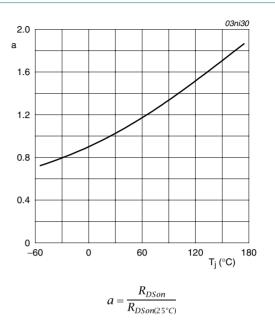


Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature

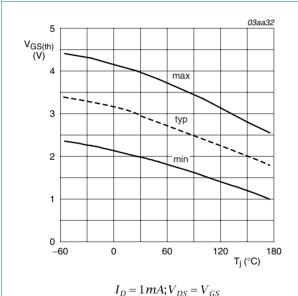
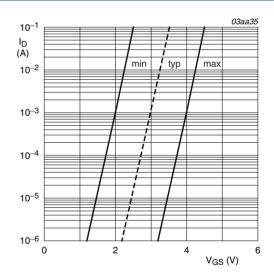


Fig 9. Gate-source threshold voltage as a function of junction temperature



 $T_j = 25 \,^{\circ}C; V_{DS} = 5V$

Fig 10. Sub-threshold drain current as a function of gate-source voltage

8 of 14

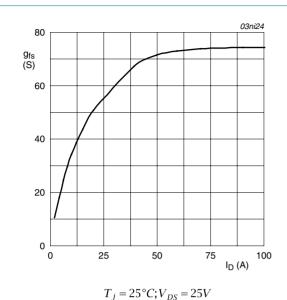
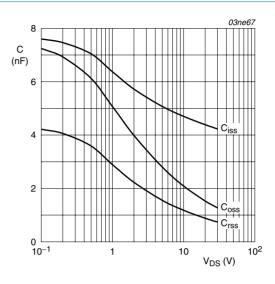


Fig 11. Forward transconductance as a function of drain current; typical values



 $V_{GS} = 0V; f = 1MHz$

Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

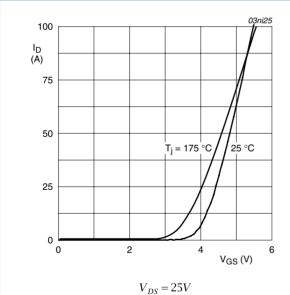
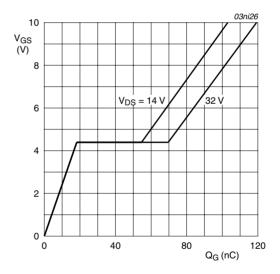


Fig 13. Transfer characteristics: drain current as a function of gate-source voltage; typical values



$$T_j = 25^{\circ}C; I_D = 25A$$

Fig 14. Gate-source voltage as a function of turn-on gate charge; typical values

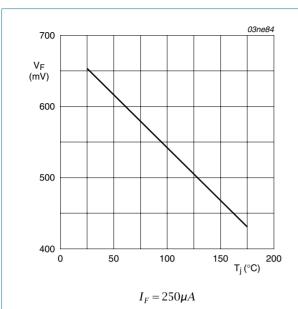
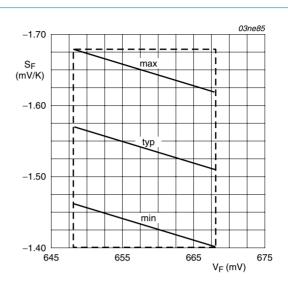


Fig 15. Forward voltage of temperature sense diode as a function of junction temperature; typical values



 V_F at $T_j = 25$ °C; $I_F = 250 \mu A$

Fig 16. Temperature coefficient of temperature sense diode as a function of forward voltage; typical values

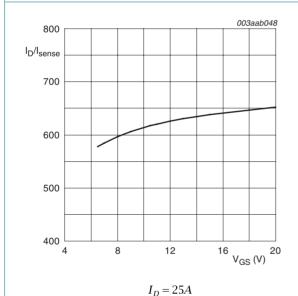


Fig 17. Drain-sense current ratio as a function of gate voltage; typical values

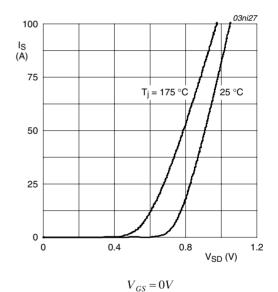


Fig 18. Source current as a function of source-drain voltage; typical values

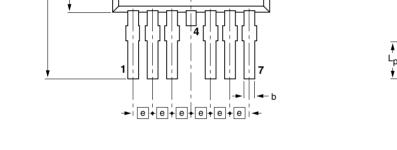
SOT427

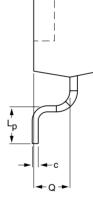
7. Package outline

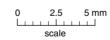
 H_{D}

D₁ mounting base

Plastic single-ended surface-mounted package (D2PAK); 7 leads (one lead cropped)







DIMENSIONS (mm are the original dimensions)

UNIT	A	A ₁	b	C	D max.	D ₁	E	е	Lp	Н _D	Ø
mm	4.50 4.10	1.40 1.27	0.85 0.60	0.64 0.46	11	1.60 1.20	10.30 9.70	1.27	2.90 2.10	15.80 14.80	2.60 2.20

OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT427						-05-03-09 06-03-16

Fig 19. Package outline SOT427 (D2PAK)

8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK7C06-40AITE_5	20090216	Product data sheet	-	BUK7C06-40AITE_4
Modifications:		of this data sheet has bee of NXP Semiconductors.	n redesigned to comply	with the new identity
	 Legal texts 	have been adapted to the	new company name wh	ere appropriate.
BUK7C06-40AITE_4	20050623	Product data sheet	-	BUK7C06-40AITE_3
BUK7C06-40AITE_3 (9397 750 15176)	20050616	Product data sheet	-	BUK7C06_40AITE-02
BUK7C06_40AITE-02 (9397 750 12487)	20040129	Product data sheet	-	BUK7C06_40AITE-01
BUK7C06_40AITE-01 (9397 750 09873)	20020717	Product data sheet	-	-

9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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10. Contact information

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For sales office addresses, please send an email to: salesaddresses@nxp.com

BUK7C06-40AITE

N-channel TrenchPLUS standard level FET

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Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.

